

Search Notes	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/811,856	NAKANO ET AL.
Examiner	Art Unit	
Yaima Campos	2185	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EIC Plus Search	11/18/2005	YC
PALM and EAST inventor name search	11/18/2005	YC
Text search within subclases 711/711/129,147,170-173	11/18/2005	YC
Text search within subclasses 711/111-115,147-154,161- 165,168,170-173 707/100-101,200- 206,1,8,2,115,214,216,217	11/18/2005	YC
Non-patent literature text search on IEEE Xplore	11/18/2005	YC

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner